

## ADG508F/ADG509F Fab Transfer

Qualification Plan for the Transfer of the ADG508F/ADG509F to ADI Limerick 8 inch Wafer Fab

Test	Standard	Conditions	Results
High Temperature Operating Life (HTOL)	JEDEC JESD22-A108	1000 hours at 125C Biased	Passed
High Temperature Storage Life (HTSL)	JEDEC JESD22-A103	1000 Hours at 150C	Passed
Early Life Failure (ELF)	Mil-STD-883, Method 1015	48 hours at 125C Biased	Passed
Electrostatic Discharge Human Body Model	ANSI/ESDA/JEDEC JS-001-2010	Std Sample 1Zap per polarity	Passed
Latch-up	JEDEC Standard 78	+25C Biased single duration 100/99mA	Passed